Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/713,533	KIM ET AL.
Examiner	Art Unit
Anh Q. Tran	2819

	SEAR	CHED	
Class	Subclass	Date	Examiner
326	59 60	3/3/05	AT
	62-63	,	
	62-63 80-82		
	90		-6
			ē

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
as	ahove	3/3/05	AT	
		, ,		
		!		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East: attach		47		
,				
•				
· · · · · · · · · · · · · · · · · · ·				